

### Half-Bridge

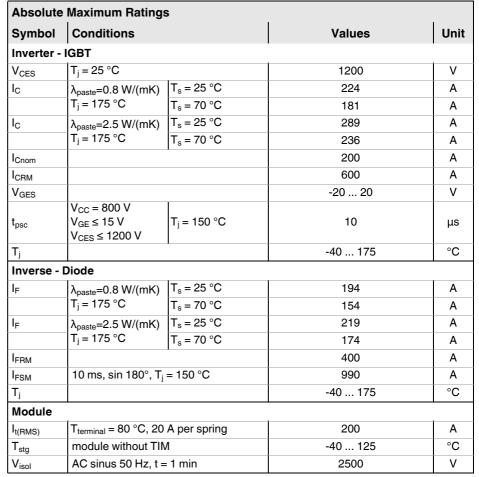
#### SKiiP 26GB12T4V1

#### Features\*

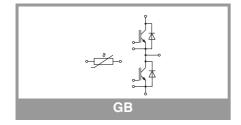
- Trench 4 IGBTs
- Robust and soft freewheeling diodes in CAL technology
- Highly reliable spring contacts for electrical connections
- UL recognised: File no. E63532
- NTC T-Sensor

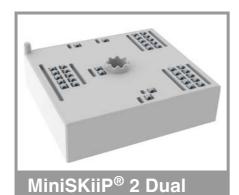
#### Remarks

- Max. case temperature limited to T<sub>C</sub>= 125°C
- Product reliability results valid for T<sub>j</sub>≤150°C (recommended T<sub>j,op</sub>=-40...+150°C)



| Characteristics         |  |                              |      |       |              |     |  |  |
|-------------------------|--|------------------------------|------|-------|--------------|-----|--|--|
| Symbol                  | Conditions   | min.                         | typ. | max.  | Unit         |     |  |  |
| Inverter -              | nverter - IGBT   |                              |      |       |              |     |  |  |
| V <sub>CE(sat)</sub>    | $I_{\rm C} = 200  {\rm A}$   | T <sub>j</sub> = 25 °C       |      | 1.80  | 2.05         | V   |  |  |
|                         | V <sub>GE</sub> = 15 V<br>chiplevel  | T <sub>j</sub> = 150 °C      |      | 2.20  | 2.40         | V   |  |  |
| V <sub>CE0</sub> chiple | chiplevel  | T <sub>j</sub> = 25 °C       |      | 0.80  | 0.90         | V   |  |  |
|                         | Criipievei   | T <sub>j</sub> = 150 °C      |      | 0.70  | 2.05<br>2.40 | V   |  |  |
| r <sub>CE</sub>         | V <sub>GE</sub> = 15 V   | T <sub>j</sub> = 25 °C       |      | 5.0   | 5.8          | mΩ  |  |  |
|                         | chiplevel  | T <sub>j</sub> = 150 °C      |      | 7.5   | 8.0          | mΩ  |  |  |
| $V_{GE(th)}$            | $V_{GE} = V_{CE}, I_{C} = 12 \text{ r}$  | nA                           | 5    | 5.8   | 6.5          | V   |  |  |
| I <sub>CES</sub>        | $V_{GE} = 0 \text{ V}, V_{CE} = 12$  | 00 V, T <sub>j</sub> = 25 °C |      |       | 2.0          | mA  |  |  |
| C <sub>ies</sub>        | V <sub>CE</sub> = 25 V<br>V <sub>GF</sub> = 0 V  | f = 1 MHz                    |      | 12.30 |              | nF  |  |  |
| C <sub>oes</sub>        |  | f = 1 MHz                    |      | 0.81  |              | nF  |  |  |
| C <sub>res</sub>        |  | f = 1 MHz                    |      | 0.69  |              | nF  |  |  |
| $Q_{G}$                 | V <sub>GE</sub> = - 8 V+ 15 V  |                              |      | 1130  |              | nC  |  |  |
| R <sub>Gint</sub>       | T <sub>j</sub> = 25 °C   |                              |      | 3.8   |              | Ω   |  |  |
| t <sub>d(on)</sub>      | V <sub>CC</sub> = 600 V  | T <sub>j</sub> = 150 °C      |      | 170   |              | ns  |  |  |
| t <sub>r</sub>          | I <sub>C</sub> = 200 A   | T <sub>j</sub> = 150 °C      |      | 45    |              | ns  |  |  |
| E <sub>on</sub>         | $\begin{aligned} R_{G \text{ on}} &= 2 \ \Omega \\ R_{G \text{ off}} &= 2 \ \Omega \\ \text{di/dt}_{\text{on}} &= 5500 \ \text{A/}\mu\text{s} \\ \text{di/dt}_{\text{off}} &= 2000 \ \text{A/}\mu\text{s} \end{aligned}$ | T <sub>j</sub> = 150 °C      |      | 13.6  |              | mJ  |  |  |
| t <sub>d(off)</sub>     |  | T <sub>j</sub> = 150 °C      |      | 440   |              | ns  |  |  |
| t <sub>f</sub>          |  | T <sub>j</sub> = 150 °C      |      | 91    |              | ns  |  |  |
| E <sub>off</sub>        |  | T <sub>j</sub> = 150 °C      |      | 22.1  |              | mJ  |  |  |
| R <sub>th(j-s)</sub>    | per IGBT, λ <sub>paste</sub> =0.8 W/(mK)   |                              |      | 0.25  |              | K/W |  |  |
| R <sub>th(j-s)</sub>    | per IGBT, λ <sub>paste</sub> =2.5  | 5 W/(mK)                     |      | 0.16  |              | K/W |  |  |





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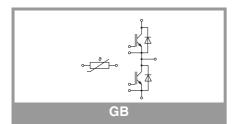
#### Features\*

- Trench 4 IGBTs
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#### **Remarks**

- Max. case temperature limited to  $T_C$ = 125°C
- Product reliability results valid for  $T_j \le 150^{\circ}\text{C}$  (recommended  $T_{j,\text{op}} = -40... + 150^{\circ}\text{C}$ )

| Characteristics      |   |                         |      |      |   |      |  |
|----------------------|---|-------------------------|------|------|---|------|--|
| Symbol               | Conditions  |                         | min. | typ. | max.  | Unit |  |
| Inverse - Diode      |   |                         |      |      |   |      |  |
| $V_F = V_{EC}$       | I <sub>F</sub> = 200 A                                      | T <sub>j</sub> = 25 °C  |      | 2.20 | 2.52  | V    |  |
|                      | V <sub>GE</sub> = 0 V<br>chiplevel                          | T <sub>j</sub> = 150 °C |      | 2.15 | 2.47  | V    |  |
| $V_{F0}$             | chiplevel   | T <sub>j</sub> = 25 °C  |      | 1.30 | 1.50  | V    |  |
|                      | Chipievei   | T <sub>j</sub> = 150 °C |      | 0.90 | 20 2.52<br>15 2.47<br>30 1.50<br>90 1.10<br>3.5 5.1<br>3.3 6.9<br>28<br>32<br>3.4<br>34<br>28 | V    |  |
| r <sub>F</sub>       | chiplevel   | T <sub>j</sub> = 25 °C  |      | 4.5  | 5.1   | mΩ   |  |
|                      | Criipievei  | T <sub>j</sub> = 150 °C |      | 6.3  | 6.9   | mΩ   |  |
| I <sub>RRM</sub>     | di/dt <sub>off</sub> = 5215 A/μs<br>V <sub>GF</sub> = -15 V | T <sub>j</sub> = 150 °C |      | 228  |   | Α    |  |
| Q <sub>rr</sub>      |   | T <sub>j</sub> = 150 °C |      | 32   |   | μC   |  |
| E <sub>rr</sub>      |   | T <sub>j</sub> = 150 °C |      | 13.4 |   | mJ   |  |
| R <sub>th(j-s)</sub> | per Diode, λ <sub>paste</sub> =0.8 W/(mK)                   |                         |      | 0.34 |   | K/W  |  |
| R <sub>th(j-s)</sub> | per Diode, λ <sub>paste</sub> =2.5 W/(mK)                   |                         | 0.28 |      |   | K/W  |  |
| Module               |   |                         |      |      |   |      |  |
| L <sub>CE</sub>      |   |                         |      | 20   |   | nΗ   |  |
| Ms                   | to heat sink  |                         | 2    |      | 2.5   | Nm   |  |
| w                    |   |                         |      | 50   |   | g    |  |
| Temperature Sensor   |   |                         |      |      |   |      |  |
| R <sub>100</sub>     | T <sub>c</sub> =100°C (R <sub>25</sub> =5 ks                |                         | Ω    |      |   |      |  |
| B <sub>25/85</sub>   | R <sub>(T)</sub> =R <sub>25</sub> *exp[B <sub>25/85</sub>   |                         | K    |      |   |      |  |



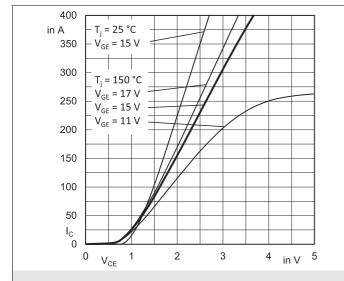


Fig. 1: Typ. output characteristic

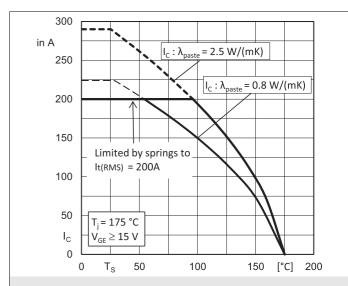


Fig. 2: Rated current vs. temperature  $I_C = f(T_S)$ 

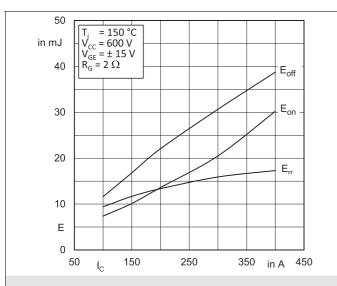


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$ 

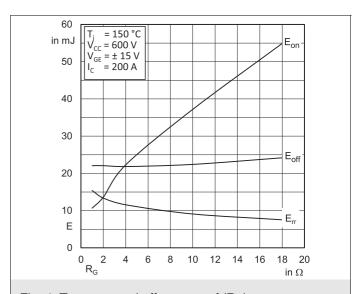


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$ 

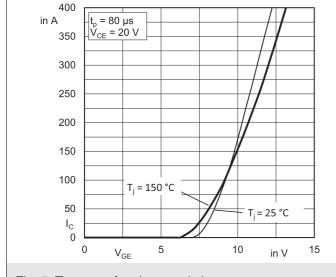


Fig. 5: Typ. transfer characteristic

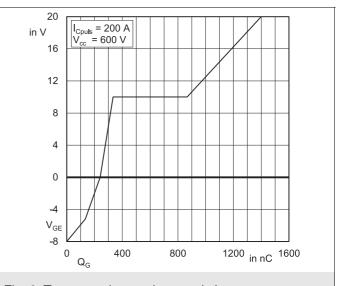
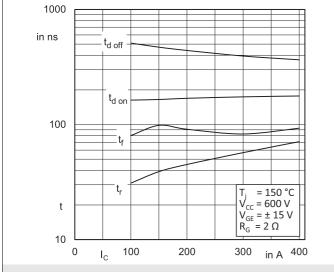


Fig. 6: Typ. gate charge characteristic



 $^{0}$   $_{\rm I_{C}}$   $^{100}$   $^{200}$   $^{300}$   $_{\rm in\ A}$   $^{400}$  Fig. 7: Typ. switching times vs.  $_{\rm I_{C}}$ 

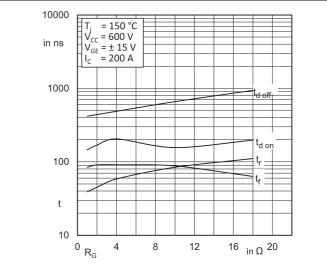


Fig. 8: Typ. switching times vs. gate resistor  $R_{\text{G}}$ 

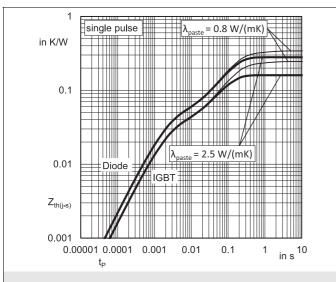


Fig. 9: Typ. transient thermal impedance

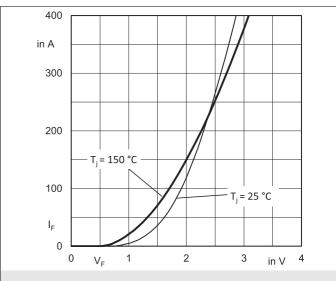


Fig. 10: Typ. CAL diode forward characteristic

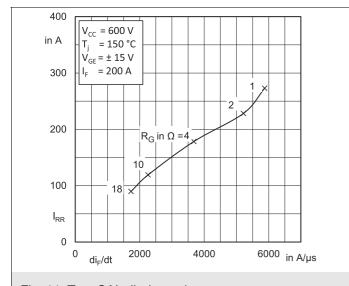


Fig. 11: Typ. CAL diode peak reverse recovery current

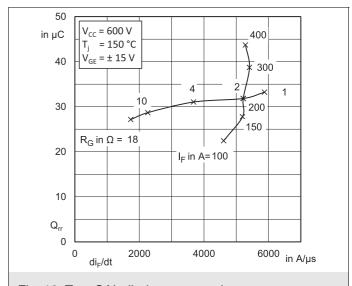
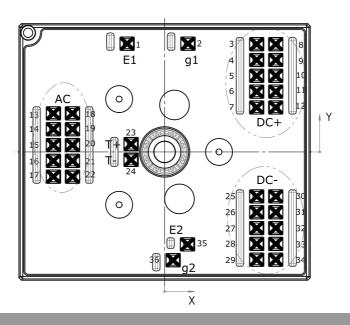


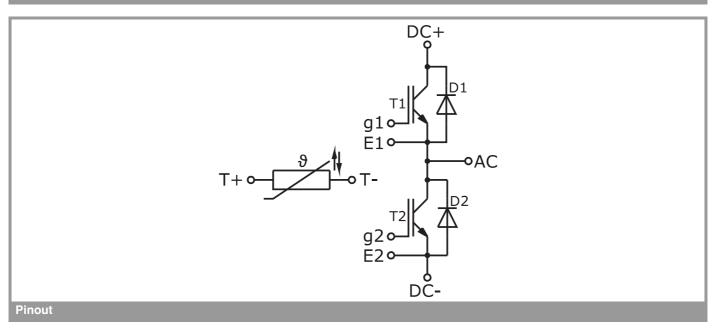
Fig. 12: Typ. CAL diode recovery charge

| Pin out |        |      |          |     |        |       |          |
|---------|--------|------|----------|-----|--------|-------|----------|
| Pin     | X      | Υ    | Function | Pin | X      | Y     | Function |
| 1       | -7,58  | 21,9 | E1       | 19  | -18,63 | 4,6   | AC       |
| 2       | 4,73   | 21,9 | g1       | 20  | -18,63 | 1,4   | AC       |
| 3       | 18,63  | 21,8 | DC+      | 21  | -18,63 | -1,8  | AC       |
| 4       | 18,63  | 18,6 | DC+      | 22  | -18,63 | -5    | AC       |
| 5       | 18,63  | 15,4 | DC+      | 23  | -6,78  | 1,6   | T+       |
| 6       | 18,63  | 12,2 | DC+      | 24  | -6,78  | -1,6  | T-       |
| 7       | 18,63  | 9    | DC+      | 25  | 18,63  | -9    | DC-      |
| 8       | 22,48  | 21,8 | DC+      | 26  | 18,63  | -12,2 | DC-      |
| 9       | 22,48  | 18,6 | DC+      | 27  | 18,63  | -15,4 | DC-      |
| 10      | 22,48  | 15,4 | DC+      | 28  | 18,63  | -18,6 | DC-      |
| 11      | 22,48  | 12,2 | DC+      | 29  | 18,63  | -21,8 | DC-      |
| 12      | 22,48  | 9    | DC+      | 30  | 22,48  | -9    | DC-      |
| 13      | -22,48 | 7,8  | AC       | 31  | 22,48  | -12,2 | DC-      |
| 14      | -22,48 | 4,6  | AC       | 32  | 22,48  | -15,4 | DC-      |
| 15      | -22,48 | 1,4  | AC       | 33  | 22,48  | -18,6 | DC-      |
| 16      | -22,48 | -1,8 | AC       | 34  | 22,48  | -21,8 | DC-      |
| 17      | -22,48 | -5   | AC       | 35  | 4,63   | -18,7 | E2       |
| 18      | -18,63 | 7,8  | AC       | 36  | 1,73   | -21,9 | g2       |

all values in [mm]



### **Pinout and Dimensions**



This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

#### \*IMPORTANT INFORMATION AND WARNINGS

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